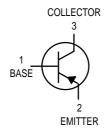
# **General Purpose Transistors PNP Silicon**

# BCW69LT1 BCW70LT1





#### **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	VCEO	-45	Vdc
Emitter-Base Voltage	VEBO	-5.0	Vdc
Collector Current — Continuous	IC	-100	mAdc

#### **DEVICE MARKING**

BCW69LT1 = H1; BCW70LT1 = H2

# THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation FR-5 Board (1)  TA = 25°C	PD	225	mW
Derate above 25°C		1.8	mW/°C
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	556	°C/W
Total Device Dissipation Alumina Substrate, (2) T <sub>A</sub> = 25°C	PD	300	mW
Derate above 25°C		2.4	mW/°C
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	417	°C/W
Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C

# **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS					
Collector–Emitter Breakdown Voltage (I <sub>C</sub> = -2.0 mAdc, I <sub>B</sub> = 0)	V(BR)CEO	<b>-45</b>	_	Vdc	
Collector–Emitter Breakdown Voltage (I <sub>C</sub> = –100 μAdc, V <sub>EB</sub> = 0)	V(BR)CES	-50	_	Vdc	
Emitter–Base Breakdown Voltage (I <sub>E</sub> = -10 μAdc, I <sub>C</sub> = 0)		-5.0	_	Vdc	
Collector Cutoff Current (V <sub>CB</sub> = -20 Vdc, I <sub>E</sub> = 0) (V <sub>CB</sub> = -20 Vdc, I <sub>E</sub> = 0, T <sub>A</sub> = 100°C)	I <sub>CBO</sub>	_ _ _	-100 -10	nAdc μAdc	

- 1. FR-5 = 1.0 x 0.75 x 0.062 in.
- 2. Alumina = 0.4 x 0.3 x 0.024 in. 99.5% alumina

Thermal Clad is a trademark of the Bergquist Company



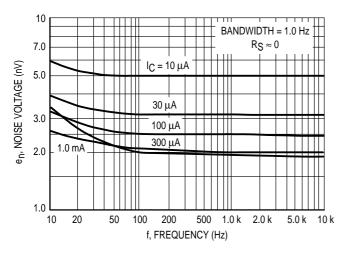
# **ELECTRICAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted) (Continued)

		•				
Characteristic	Symbol	Min	Max	Unit		
ON CHARACTERISTICS						
DC Current Gain $(I_{C} = -2.0 \text{ mAdc}, V_{CE} = -5.0 \text{ Vdc}) \\ \text{BCW69} \\ \text{BCW70}$	hFE	120 215	260 500	_		
Collector–Emitter Saturation Voltage (I <sub>C</sub> = -10 mAdc, I <sub>B</sub> = -0.5 mAdc)		_	-0.3	Vdc		
Base–Emitter On Voltage (I <sub>C</sub> = -2.0 mAdc, V <sub>CE</sub> = -5.0 Vdc)	V <sub>BE(on)</sub>	-0.6	-0.75	Vdc		
SMALL-SIGNAL CHARACTERISTICS						
Output Capacitance ( $I_E = 0$ , $V_{CB} = -10$ Vdc, $f = 1.0$ MHz)	C <sub>obo</sub>	_	7.0	pF		
Noise Figure (I <sub>C</sub> = $-0.2$ mAdc, V <sub>CE</sub> = $-5.0$ Vdc, R <sub>S</sub> = $2.0$ k $\Omega$ , f = $1.0$ kHz, BW = $200$ Hz)	NF	_	10	dB		



#### TYPICAL NOISE CHARACTERISTICS

 $(V_{CE} = -5.0 \text{ Vdc}, T_A = 25^{\circ}C)$ 



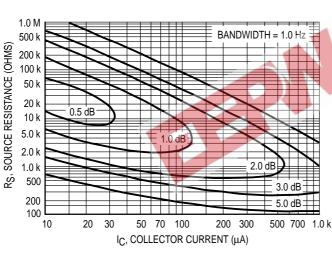
1.0 7.0 BANDWIDTH = 1.0 H 5.0  $I_C = 1.0 \text{ mA}$ In, NOISE CURRENT (pA) 3.0 2.0 300 uA 1.0 0.7 0.5 0.3 0.2 10 μΑ 0.1 1.0 k 2.0 k 10 50 200 500 5.0 k 10 k f, FREQUENCY (Hz)

Figure 1. Noise Voltage

Figure 2. Noise Current

#### **NOISE FIGURE CONTOURS**

 $(VCE = -5.0 \text{ Vdc}, T_A = 25^{\circ}C)$ 



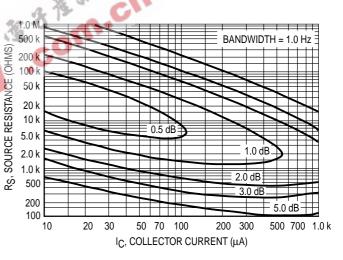


Figure 3. Narrow Band, 100 Hz

Figure 4. Narrow Band, 1.0 kHz

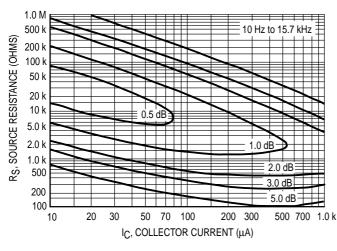


Figure 5. Wideband

Noise Figure is Defined as:

$$NF = 20 \log_{10} \left[ \frac{e_n^2 + 4KTR_S + I_n^2 R_S^2}{4KTR_S} \right]^{1/2}$$

 $e_{\mbox{\scriptsize n}}$  = Noise Voltage of the Transistor referred to the input. (Figure 3)

In = Noise Current of the Transistor referred to the input. (Figure 4)

 $K = Boltzman's Constant (1.38 x 10^{-23} j/{}^{\circ}K)$ 

T = Temperature of the Source Resistance (°K)

Rs = Source Resistance (Ohms)

#### TYPICAL STATIC CHARACTERISTICS

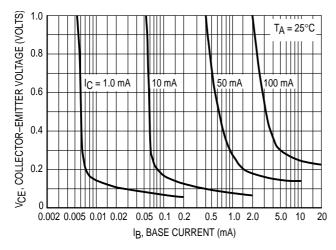
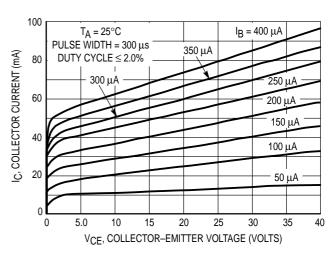


Figure 6. Collector Saturation Region



**Figure 7. Collector Characteristics** 

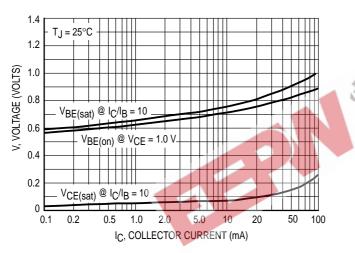
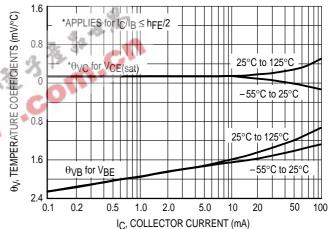


Figure 8. "On" Voltages

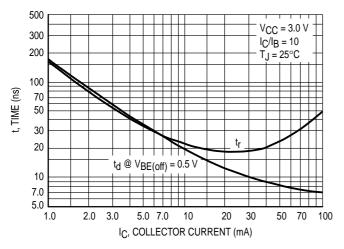


**Figure 9. Temperature Coefficients** 

T<sub>J</sub> = 25°C

50

#### TYPICAL DYNAMIC CHARACTERISTICS



1000  $V_{CC} = -3.0 \text{ V}$ 700  $I_C/I_B = 10$ 500 I<sub>B1</sub> = I<sub>B2</sub> T<sub>J</sub> = 25°C 300 200 t, TIME (ns) 100 70 50 30 20 -1.0 -2.0 -3.0-5.0 - 7.0 - 10-20 -50 -70 -100 IC, COLLECTOR CURRENT (mA)

Figure 10. Turn-On Time

Figure 11. Turn-Off Time

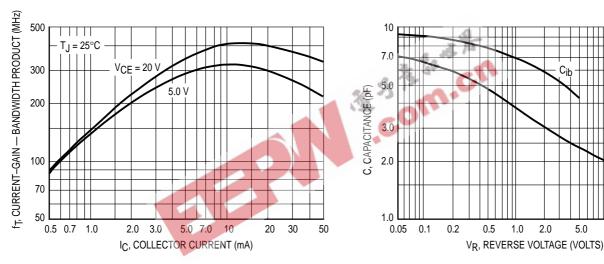


Figure 12. Current-Gain — Bandwidth Product

Figure 13. Capacitance

2.0

5.0

10

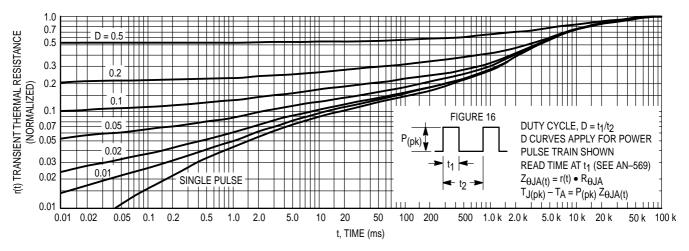


Figure 14. Thermal Response

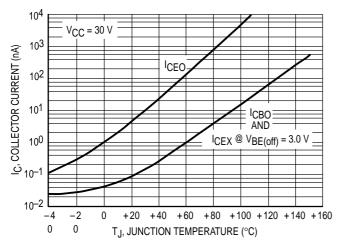


Figure 15. Typical Collector Leakage Current

#### **DESIGN NOTE: USE OF THERMAL RESPONSE DATA**

A train of periodical power pulses can be represented by the model as shown in Figure 16. Using the model and the device thermal response the normalized effective transient thermal resistance of Figure 14 was calculated for various duty cycles.

To find  $Z_{\theta JA(t)}$ , multiply the value obtained from Figure 14 by the steady state value  $R_{\theta JA}$ .

Example:

Dissipating 2.0 watts peak under the following conditions:

 $t_1 = 1.0 \text{ ms}, t_2 = 5.0 \text{ ms} (D = 0.2)$ 

Using Figure 14 at a pulse width of 1.0 ms and D = 0.2, the reading of r(t) is 0.22.

The peak rise in junction temperature is therefore  $\Delta T = r(t) \times P_{(pk)} \times R_{\theta J} = 0.22 \times 2.0 \times 200 = 88^{\circ}C.$ 

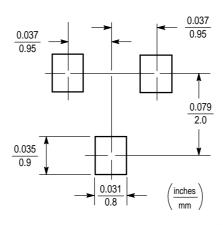
For more information, see AN-569.



#### INFORMATION FOR USING THE SOT-23 SURFACE MOUNT PACKAGE

#### MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to insure proper solder connection interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



SOT-23

#### SOT-23 POWER DISSIPATION

The power dissipation of the SOT–23 is a function of the pad size. This can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by  $T_{J(max)}$ , the maximum rated junction temperature of the die,  $R_{\theta JA}$ , the thermal resistance from the device junction to ambient, and the operating temperature,  $T_A$ . Using the values provided on the data sheet for the SOT–23 package,  $P_D$  can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta,JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature T<sub>A</sub> of 25°C, one can calculate the power dissipation of the device which in this case is 225 milliwatts.

$$P_D = \frac{150^{\circ}C - 25^{\circ}C}{556^{\circ}C/W} = 225 \text{ milliwatts}$$

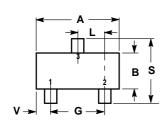
The 556°C/W for the SOT–23 package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 225 milliwatts. There are other alternatives to achieving higher power dissipation from the SOT–23 package. Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad™. Using a board material such as Thermal Clad, an aluminum core board, the power dissipation can be doubled using the same footprint.

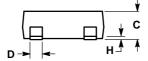
#### **SOLDERING PRECAUTIONS**

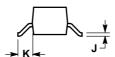
The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- · Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.\*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.
- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes.
   Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.
- \* Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.

#### PACKAGE DIMENSIONS







**CASE 318-08** 

#### NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14 5M 1982
- CONTROLLING DIMENSION: INCH.
- 2. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.1102	0.1197	2.80	3.04
В	0.0472	0.0551	1.20	1.40
С	0.0350	0.0440	0.89	1.11
D	0.0150	0.0200	0.37	0.50
G	0.0701	0.0807	1.78	2.04
Н	0.0005	0.0040	0.013	0.100
J	0.0034	0.0070	0.085	0.177
K	0.0180	0.0236	0.45	0.60
L	0.0350	0.0401	0.89	1.02
S	0.0830	0.0984	2.10	2.50
٧	0.0177	0.0236	0.45	0.60

STYLE 6: PIN 1. BASE

2. EMITTER

COLLECTOR

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